PATENT 81790.0214 E #13/C 9/26/2 Surler

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Art Unit:

2815

Tomomi MOMOHARA

Examiner:

J. Fenty

Serial No.: 09/511,620

Filed: February 23, 2000

For:

SEMICONDUCTOR INTEGRATED CIRCUIT

DEVICE HAVING A PLURALITY OF WELLS,

TEST METHOD OF TESTING THE SEMICONDUCTOR INTEGRATED CIRCUIT DEVICE, AND TEST DEVICE

WHICH EXECUTES THE TEST METHOD

(As Amended)

I hereby certify that this correspondence is being facsimile transmitted to the United States Patent and Trademark Office, Fax No. (703) 30897722 on September 6, 2002.

lon R. Mason

Signature

Reg. No. 41.178

September 6, 2002

Da

RESPONSE TO OFFICE ACTION

Assistant Commissioner for Patents

Washington, D.C. 20231

Attention: Box Amendment

FAX COPY RECEIVED

SFP 5 2002

TECHNOLOGY CENTER 2800

Dear Sir:

In response to the Office Action mailed June 6, 2002, the three-month statutory period during which to respond thereto expiring September 6, 2002, Applicant submits the following amendments and remarks.

AMENDMENT

09/26/2002 SSIRLES 000 Description of the second control of the se

01 FC:103

162.00 CH

IN THE TITLE:

Please amend the title as indicated below:

-- SEMICONDUCTOR INTEGRATED CIRCUIT DEVICE HAVING A
PLURALITY OF WELLS, TEST METHOD OF TESTING THE SEMICONDUCTOR
INTEGRATED CIRCUIT DEVICE, AND TEST DEVICE WHICH EXECUTES THE
TEST METHOD --.